MOSFET – Power, Single, P-Channel, Enhancement Mode, SOIC-8 -10 Amps, -20 Volts

Features

- Ultra Low R_{DS(on)}
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Miniature SOIC-8 Surface Mount Package
- Diode Exhibits High Speed, Soft Recovery
- Avalanche Energy Specified
- SOIC-8 Mounting Information Provided
- Pb-Free Package is Available

Applications

• Power Management in Portable and Battery-Powered Products, i.e.: Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|---|---|---|-------------------------------|
| Drain-to-Source Voltage | V _{DSS} | -20 | Vdc |
| Gate-to-Source Voltage - Continuous | V _{GS} | ± 12 | Vdc |
| Thermal Resistance – Junction–to–Ambient (Note 1) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Maximum Operating Power Dissipation Maximum Operating Drain Current Pulsed Drain Current (Note 3) | R _{θJA} P _D I _D I _D P _D I _D I _D | 50 2.5 -10 -8.0 0.6 -5.5 -50 | °C/W W A A W A |
| Thermal Resistance – Junction–to–Ambient (Note 2) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Maximum Operating Power Dissipation Maximum Operating Drain Current Pulsed Drain Current (Note 3) | R _{θJA} P _D I _D I _D I _D I _{DM} | 80 1.6 -8.8 -6.4 0.4 -4.5 -44 | °C/W W A A W A |
| Operating and Storage Temperature Range | T _J , T _{stg} | -55 to +150 | °C |
| | E _{AS} | 500 | mJ |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds | TL | 260 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1

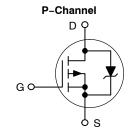
- Mounted onto a 2" square FR-4 Board (1 in sq, Cu 0.06" thick single sided), t = 10 seconds.
- 2. Mounted onto a 2" square FR-4 Board (1 in sq, Cu 0.06" thick single sided), t = steady state.



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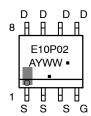
-10 AMPERES -20 VOLTS 14 m Ω @ V_{GS} = -4.5 V



MARKING DIAGRAM & PIN ASSIGNMENT



SOIC-8 CASE 751 STYLE 12



E10P02 = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week ■ Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|---------------------|-----------------------|
| NTMS10P02R2 | SOIC-8 | 2500/Tape & Reel |
| NTMS10P02R2G | SOIC-8 (Pb-Free) | 2500/Tape & Reel |

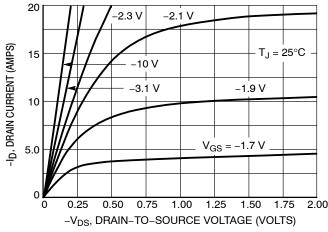
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

| 3. | 3. Pulse Test: Pulse Width < 300 μs, Duty Cycle < 2%. | |
|----|---|--|
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ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted) (Note 4)

| Characteristic | | | Min | Тур | Max | Unit |
|--|---|---------------------|-----------|----------------|----------------|--------------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-to-Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = -250 \mu\text{Adc})$ Temperature Coefficient (Positive) | | | -20 - | - -12.1 | - | Vdc mV/°C |
| Zero Gate Voltage Drain Current | | lann | | 12.1 | | μAdc |
| $(V_{DS} = -20 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J}$ $(V_{DS} = -20 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J}$ | | I _{DSS} | - - | - - | -1.0 -5.0 | μλαο |
| Gate-Body Leakage Current (V _{GS} = -12 Vdc, V _{DS} = 0 Vdc) | | I _{GSS} | - | - | -100 | nAdc |
| Gate-Body Leakage Current (V _{GS} = +12 Vdc, V _{DS} = 0 Vdc) | | I _{GSS} | - | - | 100 | nAdc |
| ON CHARACTERISTICS | | | | | | |
| Gate Threshold Voltage $(V_{DS}=V_{GS},I_{D}=-250\;\mu\text{Adc})$ Temperature Coefficient (Negative) | | V _{GS(th)} | -0.6 - | -0.88 2.8 | -1.20 - | Vdc mV/°C |
| Static Drain-to-Source On-State R ($V_{GS} = -4.5 \text{ Vdc}, I_D = -10 \text{ Adc}$) ($V_{GS} = -2.5 \text{ Vdc}, I_D = -8.8 \text{ Adc}$) | desistance | R _{DS(on)} | - - | 0.012 0.017 | 0.014 0.020 | Ω |
| Forward Transconductance (V _{DS} = | −10 Vdc, I _D = −10 Adc) | 9FS | = | 30 | - | Mhos |
| YNAMIC CHARACTERISTICS | | | | | | |
| Input Capacitance | | C _{iss} | - | 3100 | 3640 | pF |
| Output Capacitance | $(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, $ f = 1.0 MHz) | C _{oss} | _ | 1100 | 1670 | |
| Reverse Transfer Capacitance | , | C _{rss} | _ | 475 | 1010 | |
| SWITCHING CHARACTERISTICS (N | Notes 5 & 6) | | | | | |
| Turn-On Delay Time | | t _{d(on)} | - | 25 | 35 | ns |
| Rise Time | $(V_{DD} = -10 \text{ Vdc}, I_D = -1.0 \text{ Adc}, V_{GS} = -4.5 \text{ Vdc},$ | t _r | _ | 40 | 65 | |
| Turn-Off Delay Time | $R_G = 6.0 \Omega$) | t _{d(off)} | _ | 110 | 190 | |
| Fall Time | | t _f | - | 110 | 190 | |
| Turn-On Delay Time | | t _{d(on)} | - | 25 | - | ns |
| Rise Time | $(V_{DD} = -10 \text{ Vdc}, I_D = -10 \text{ Adc}, V_{GS} = -4.5 \text{ Vdc},$ | t _r | - | 100 | - | |
| Turn-Off Delay Time | $R_{G} = -4.5 \text{ Vac},$ $R_{G} = 6.0 \Omega)$ | t _{d(off)} | - | 100 | - | |
| Fall Time | | t _f | _ | 125 | - | |
| Total Gate Charge | (V _{DS} = -10 Vdc, | Q _{tot} | - | 48 | 70 | nC |
| Gate-Source Charge | $V_{GS} = -4.5 \text{ Vdc},$ | Q _{gs} | - | 6.5 | - | 1 |
| Gate-Drain Charge | I _D = -10 Adc) | Q _{gd} | - | 17 | - | |
| BODY-DRAIN DIODE RATINGS (No | ote 5) | | | | | |
| Diode Forward On-Voltage | $(I_S = -2.1 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = -2.1 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$ | V _{SD} | - - | -0.72 -0.60 | -1.2 - | Vdc |
| Diode Forward On-Voltage | $(I_S = -10 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = -10 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$ | V _{SD} | - - | -0.90 -0.75 | _ _ | Vdc |
| Reverse Recovery Time | | t _{rr} | - | 65 | 100 | ns |
| | $(I_S = -2.1 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s})$ | ta | - | 25 | _ | 1 |
| | J | t _b | - | 40 | - | 7 |
| Reverse Recovery Stored Charge | Q_{RR} | _ | 0.075 | _ | μС | |

- Handling precautions to protect against electrostatic discharge is mandatory.
 Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.
 Switching characteristics are independent of operating junction temperature.



_{OS}, DRAIN-TO-SOURCE VOLTAGE (VOLTS Figure 1. On-Region Characteristics

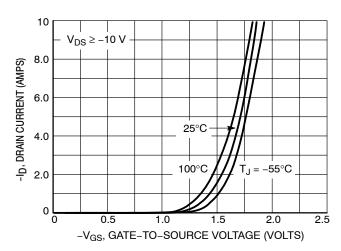


Figure 2. Transfer Characteristics

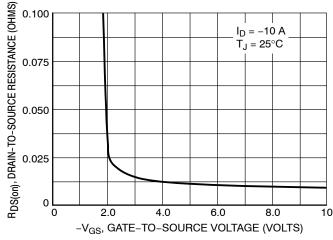


Figure 3. On-Resistance versus Gate-To-Source Voltage

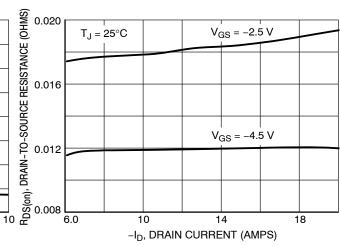


Figure 4. On-Resistance versus Drain Current and Gate Voltage

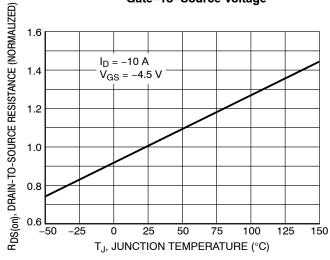


Figure 5. On–Resistance Variation with Temperature

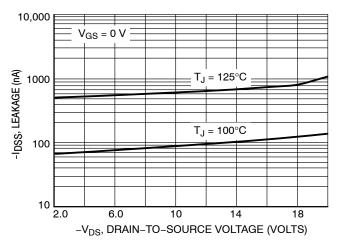
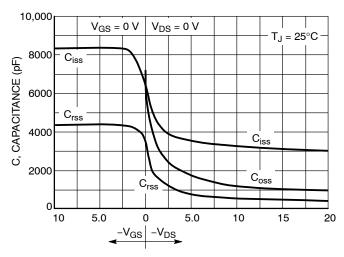


Figure 6. Drain-To-Source Leakage Current versus Voltage



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

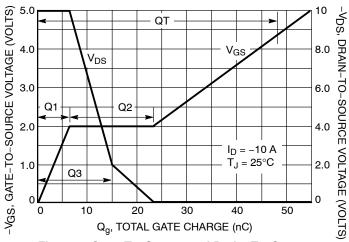


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

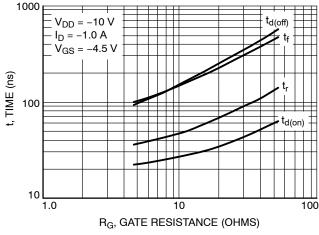


Figure 9. Resistive Switching Time Variation versus Gate Resistance

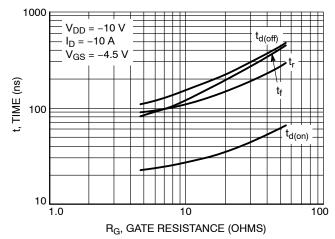


Figure 10. Resistive Switching Time Variation versus Gate Resistance

DRAIN-TO-SOURCE DIODE CHARACTERISTICS

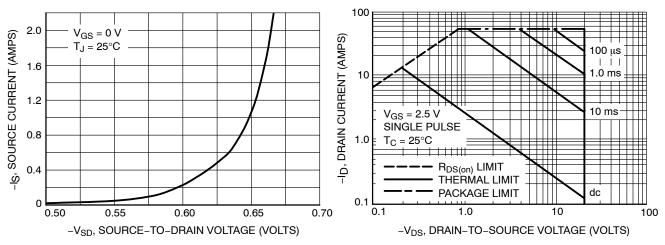


Figure 11. Diode Forward Voltage versus Current

Figure 12. Maximum Rated Forward Biased Safe Operating Area

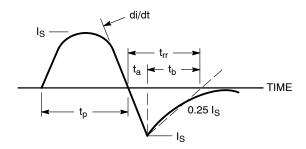


Figure 13. Diode Reverse Recovery Waveform

TYPICAL ELECTRICAL CHARACTERISTICS

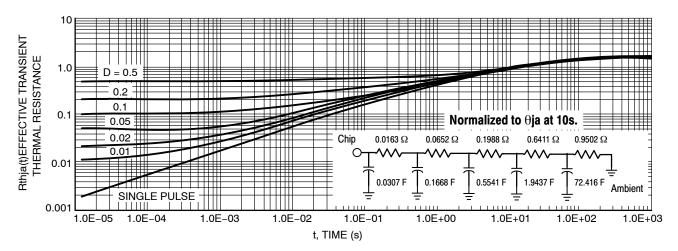


Figure 14. Thermal Response





SOIC-8 NB CASE 751-07 **ISSUE AK**

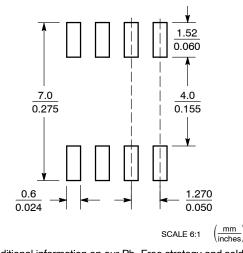
DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

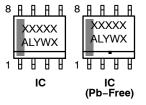
| | MILLIMETERS | | INCHES | | |
|-----|-------------|-----------|-----------|-------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | 4.80 | 5.00 | 0.189 | 0.197 | |
| В | 3.80 | 4.00 | 0.150 | 0.157 | |
| С | 1.35 | 1.75 | 0.053 | 0.069 | |
| D | 0.33 | 0.51 | 0.013 | 0.020 | |
| G | 1.27 BSC | | 0.050 BSC | | |
| Н | 0.10 | 0.10 0.25 | | 0.010 | |
| J | 0.19 | 0.25 | 0.007 | 0.010 | |
| K | 0.40 | 1.27 | 0.016 | 0.050 | |
| М | 0 ° | 8 ° | 0 ° | 8 ° | |
| N | 0.25 | 0.50 | 0.010 | 0.020 | |
| S | 5.80 | 6.20 | 0.228 | 0.244 | |

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

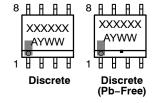
GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Wafer Lot = Year = Work Week W

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

| STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER | STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1 | STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1 | STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE |
|--|---|---|---|
| STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE | STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE | STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd | STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE. #1 |
| STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON | STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND | STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1 | STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN |
| STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN | STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN | STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON | STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1 |
| STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC | STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE | STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1 | STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN |
| STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6 | STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND | STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT | STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE |
| STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT | STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC | STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN | STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN |
| STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1 | STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1 | | |

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